

<b>Notice of References Cited</b>		Application/Control No. 09/714,325	Applicant(s)/Patent Under Reexamination PARK, SUNG-BAE	
		Examiner David J. Huisman	Art Unit 2183	Page 1 of 1

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	K	US-			
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	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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